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Substitute for form 1449B/PTO C mplete if Kn wn INFORMATION DISCLOSURE Application Numb r Unassigned ሷ STATEMENT BY APPLICANT Filing Dat wC First Nam d Inventor Eiji HIRAI et al. Date Submitted: **Group Art Unit** Unassigned (use as many sheets as necessary) Examiner Name Unassigned σ Attorney Docket Number 2 040679-1367 1 of

	U.S. PATENT DOCUMENTS							
Examiner Initials*	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of	Date of Publication of	Pages, Columns, Lines, Where Relevant		
		Number	Kind Code ² (if known)	Cited Document	Cited Document MM-DD-YYYY	Passages or Relevant Figures Appear		
with	A1	09/775,565		Yoshida et al.	08/23/2001			
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Examiner Initials*	Cite No.1	Offic	Foreign Patent Doce ³ Number ⁴	ocument Kind Code ⁵ (if known)	Name of Patentee or Applicant of Cited Documents	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶		
well	A7	JP	6-313434		Hiroshi	11/08/1994				
wed	A8	JP	11-148542		Takashi et al.	06/02/1999				
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OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS

Examiner Signature	William Clope	Date Considered	5/24/03	

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	Substitute for	or form 1449B	PTO	Complete if Known		
•	INFORMATI	ON DISCLO	SURE	Application Number	Unassigned	
STATEMENT BY APPLICANT				Filing Dat		
	Data	Submitted:		First Named Inv ntor	Eiji HIRAI et al.	
	Date	Submitted:		Group Art Unit	Unassigned	_
(use as many sheets as necessary)				Examiner Name	Unassigned	_
Sheet	2	of	2	Attorney Docket Number	040679-1367	

Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ⁶
W	A10	Surface Roughness Definitions and Designation, JAPANESE INDUSTRIAL STANDARD, 1994, PGS. 1-8, vol. B 0601, Japanese Standards Association, Tokyo, Japan.	
well	A11	Surface Texture- Instruments For The Assessment Of Surface Texture- Profiled Method, JAPANESE INDUSTRIAL STANDARD, 1996, pgs., 1-19, vol. B 065, Japanese Standards Association, Tokyo, Japan.	
wed	A12	Vickers Hardness Test- Verification Of Testing Machines, JAPANESE INDUSTRIAL STANDARD, 1997 pgs. 1-9, vol. B 7725, Japanese Standards Association, Tokyo, Japan.	
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Examiner Signature	William Clone	Date Considered	5/29/03	

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